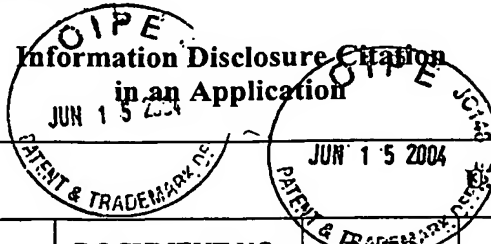


PTO-1449 <div style="text-align: center;">  </div>				Application No. 10/023,229		Applicant(s) James M. Irion II, et al.	
				Docket Number 004578.1140		Group Art Unit 2821	
<b>U.S. PATENT DOCUMENTS</b>							
		<b>DOCUMENT NO.</b>	<b>DATE</b>	<b>NAME</b>	<b>CLASS</b>	<b>SUBCLASS</b>	<b>FILING DATE</b>
τp	A	5,220,330	06/15/1993	Salvail et al.	342	62	11/04/1991
τp	B	6,222,494	04/24/2001	Erkocevic	343	790	06/23/1999
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τp	D	6,452,124	09/17/2002	York et al.	200	181	06/28/2001
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<b>FOREIGN PATENT DOCUMENTS</b>							
		<b>DOCUMENT NO.</b>	<b>DATE</b>	<b>COUNTRY</b>	<b>CLASS</b>	<b>SUBCLASS</b>	<b>TRANSLATION</b>
							<b>YES</b> <b>NO</b>
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<b>NON-PATENT DOCUMENTS</b>							
		<b>DOCUMENT (Including Author, Title, Source, and Pertinent Pages)</b>					<b>DATE</b>
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EXAMINER <i>THO PHAN</i>				DATE CONSIDERED <i>7/29/04</i>			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant. U.S. PATENT AND TRADEMARK OFFICE							